

μ PA2001C, μ PA2002C, μ PA2003C, μ PA2004C

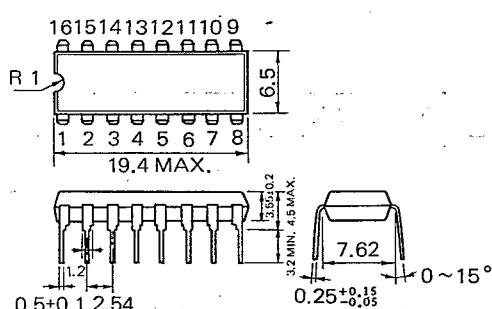
NPN SILICON EPITAXIAL DARLINGTON TRANSISTOR ARRAY

DESCRIPTION

The μ PA2001C, 2002C, 2003C and 2004C are monolithic arrays of seven darlington transistors. These devices are especially suited for driving relays, solenoids, LED, lamps, and other devices with up to 0.3 A output current per unit.

PACKAGE DIMENSIONS

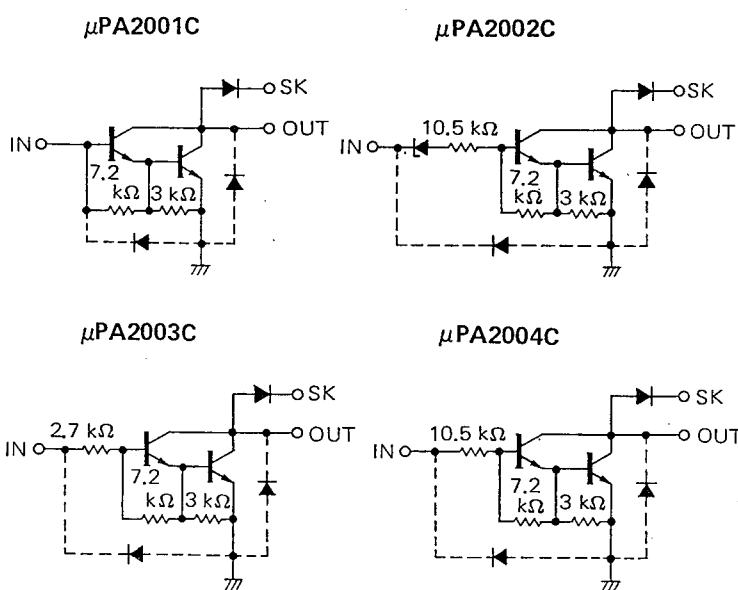
in millimeters



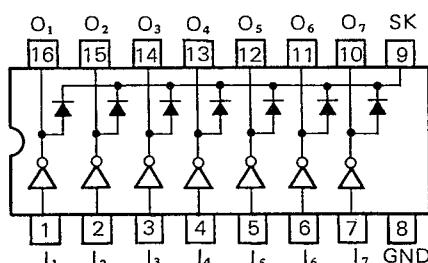
FEATURES

- Transient Protected Outputs
- High DC Current Gain
- High Output Drive Current
- High Output Voltage
- Package is 16 pin PLASTIC DIP.

EQUIVALENT CIRCUIT (1 Unit)



CONNECTION DIAGRAM (Top View)



I : Input (Base)
O : Output (Collector)
GND : (Common Emitter)
SK : Surge Killer

ABSOLUTE MAXIMUM RATINGS

Maximum Voltages and Currents (Ta = 25 °C)

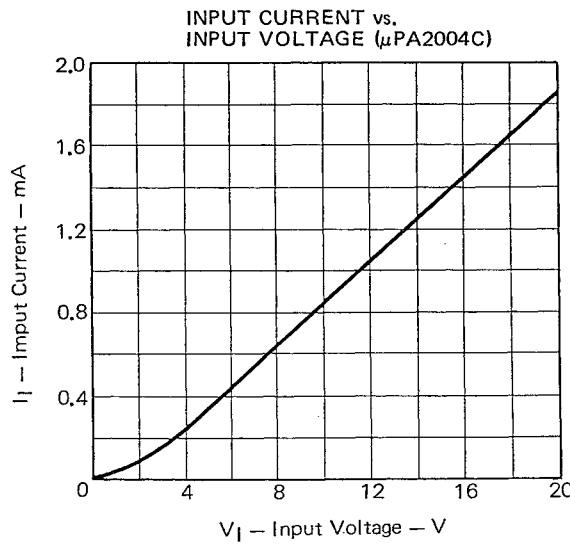
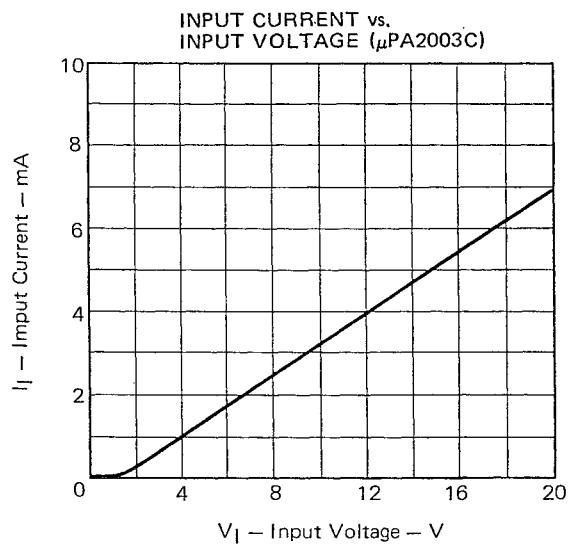
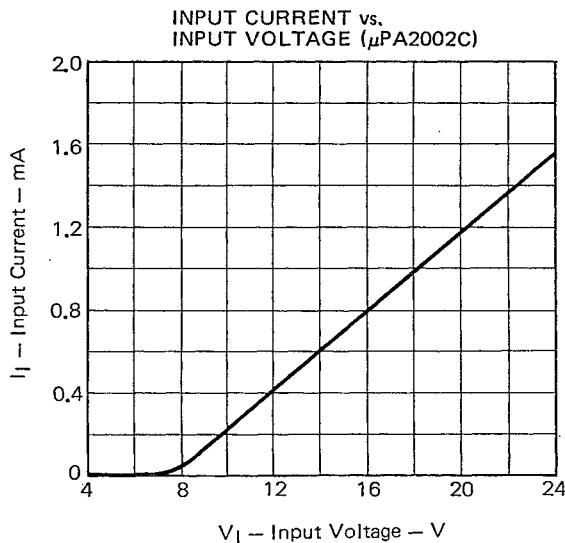
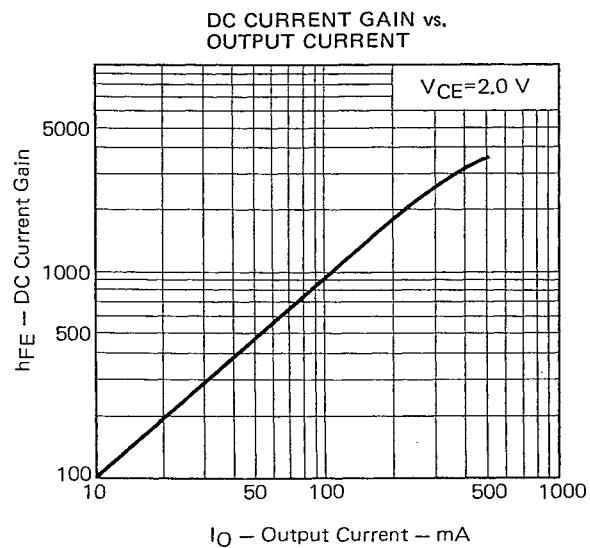
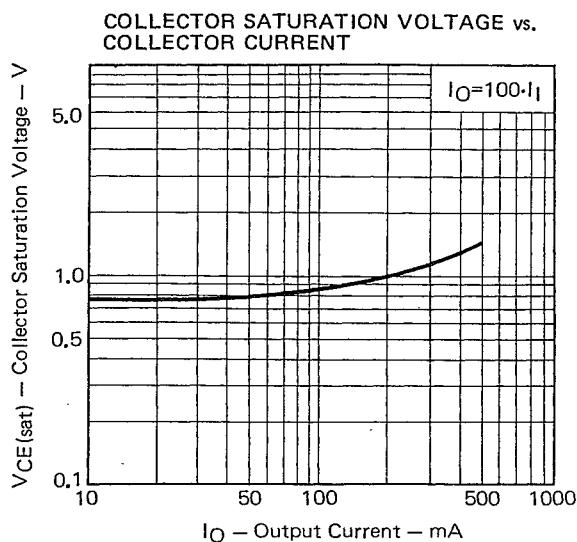
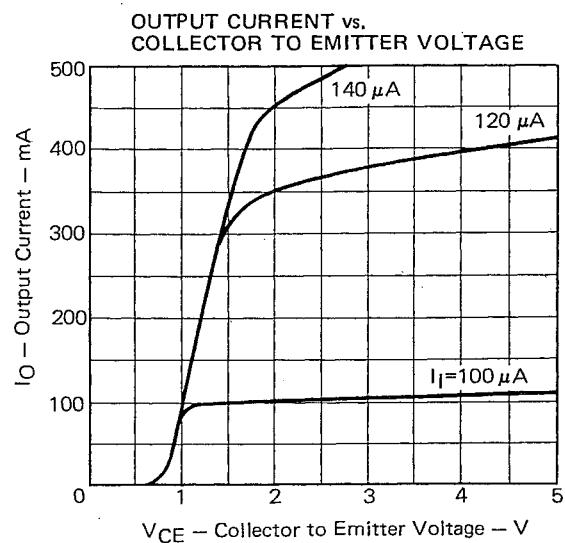
Output Voltage	VO	60	V
Input Voltage (except μPA2001C)	VI	-0.5 to +30	V
Input Current (only μPA2001C)	I _I	25	mA/unit
Output Current	I _O	500	mA/unit
Output Current	I _O *	2.3	A/package
Reverse Voltage (Clamp Diode)	V _R	60	V
Forward Current (Clamp Diode)	I _F	500	mA/unit
Maximum Power Dissipation			
Total Power Dissipation	Pd	900	mW/package
Total Power Dissipation	Pd*	2.5	W/package
Maximum Temperature			
Operating Temperature	T _{opt}	-30 to + 75	°C
Storage Temperature	T _{stg}	-55 to +150	°C

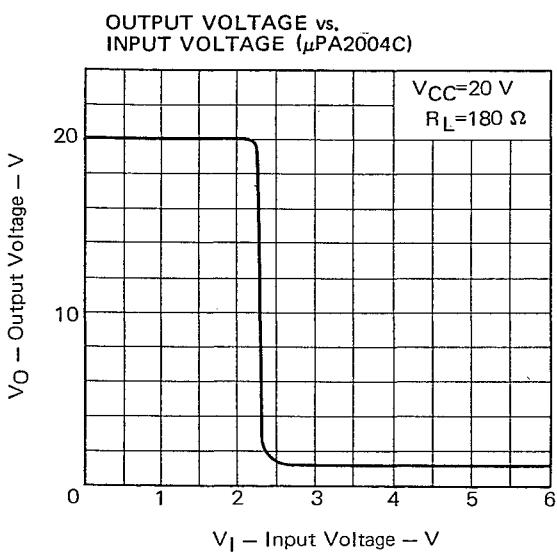
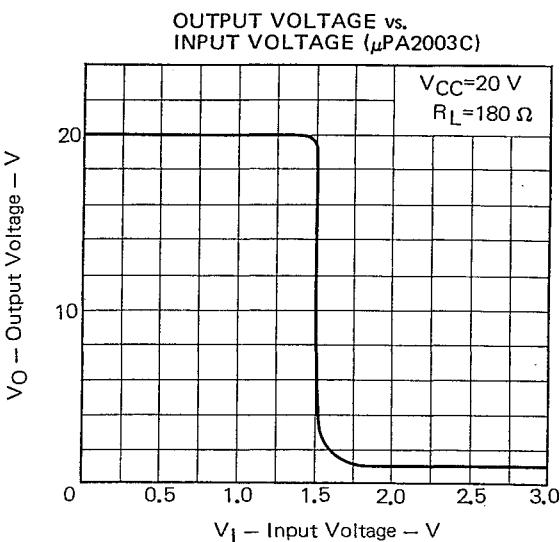
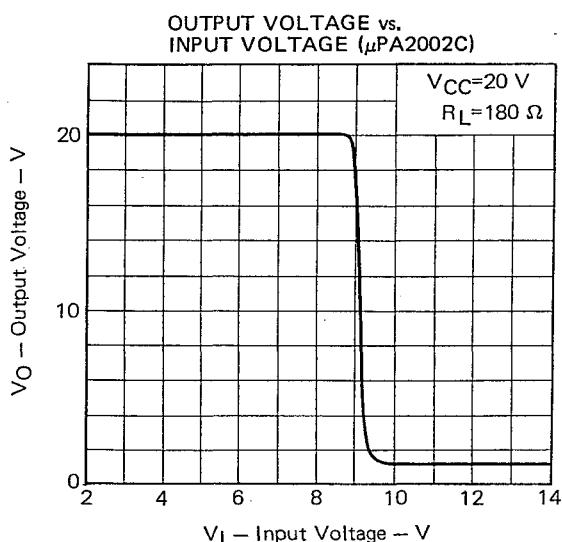
* PW≤20 ms, duty cycle≤10 %

ELECTRICAL CHARACTERISTICS (Ta = 25 °C)

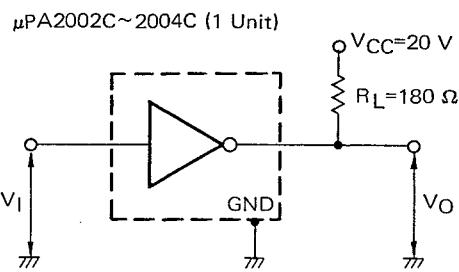
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Output Leakage Current	I _L			10	μA	V _{CE} =50 V	
				100	μA	V _{CE} =50 V, Ta=70 °C	
DC Current Gain	h _{FE}	1000	2800			V _{CE} =2.0 V, I _O =350 mA	
Collector Saturation Voltage	V _{CE(sat)}		0.9	1.1	V	I _O =100 mA, I _I =250 μA	
			1.0	1.3	V	I _O =200 mA, I _I =350 μA	
			1.2	1.6	V	I _O =350 mA, I _I =500 μA	
Input Voltage	μPA2002C	VI		11	V	V _{CE} =2.0 V, I _O =100 mA	
				12	V	V _{CE} =2.0 V, I _O =200 mA	
				13.5	V	V _{CE} =2.0 V, I _O =350 mA	
				2.0	V	V _{CE} =2.0 V, I _O =100 mA	
	μPA2003C			2.4	V	V _{CE} =2.0 V, I _O =200 mA	
				3.4	V	V _{CE} =2.0 V, I _O =350 mA	
				5.0	V	V _{CE} =2.0 V, I _O =100 mA	
				6.0	V	V _{CE} =2.0 V, I _O =200 mA	
Input Current	μPA2002C	I _I		8.0	V	V _{CE} =2.0 V, I _O =350 mA	
	μPA2003C						
	μPA2004C						
Reverse Current (Clamp Diode)	I _R			50	μA	V _R =50 V	
Forward Voltage (Clamp Diode)	V _F			2.0	V	I _F =350 mA	
Terminal Capacitance	C _t		15		pF	V _I =0, f=1.0 MHz	

Note: Input Voltage and Current of the μPA2001C depend on external resistor.

TYPICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)



VO-VI TEST CIRCUIT



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